

Die Datasheet

GB05SHT12-CAL

High Temperature Silicon Carbide Power Schottky Diode

V_{RRM} = 1200 V $I_F @ 25 \, ^{\circ}C$ = 8 A Q_C = 17 nC

Features

- 1200 V Schottky rectifier
- 250 °C maximum operating temperature
- Zero reverse recovery charge
- · Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500









Die Size = $1.6 \text{ mm} \times 1.6 \text{ mm}$

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- · Low switching losses
- · Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Down Hole Oil Drilling
- · Geothermal Instrumentation
- Solenoid Actuators
- General Purpose High-Temperature Switching
- Amplifiers
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)

Maximum Ratings at T_i = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V_{RRM}		1200	V
Continuous forward current	I _F	$T_C = 25 ^{\circ}\text{C}, R_{thJC} = 3.4$	8	Α
Continuous forward current	I _F	$T_C \le 225 ^{\circ}C, R_{thJC} = 3.4$	2.5	Α
RMS forward current	I _{F(RMS)}	$T_C \le 225 ^{\circ}C, R_{thJC} = 3.4$	4.3	Α
Surge non-repetitive forward current, Half Sine Wave	$I_{F,SM}$	$T_C = 25 ^{\circ}C, t_P = 10 \text{ms}$	30	А
Non-repetitive peak forward current	I _{F,max}	$T_C = 25 ^{\circ}\text{C}, t_P = 10 \mu\text{s}$	120	A
I ² t value	∫i² dt	$T_C = 25 ^{\circ}\text{C}, t_P = 10 \text{ms}$	5	A ² S
Power dissipation	P _{tot}	$T_C = 25 ^{\circ}\text{C}, R_{thJC} = 3.4$	66	W
Operating and storage temperature	T_{j} , T_{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Cumbal	Conditions –		Values		Unit	
	Symbol			min.	typ.	max.	Offic
Diode forward voltage	V_{F}	I _F = 2.5 A, T _j = 25 °C		1.6		V	
	٧F	I _F = 2.5 A, T _j = 250 °C		2.8			
Reverse current	ı	$V_R = 1200 \text{ V}, T_j = 25 ^{\circ}\text{C}$		1	10	μΑ	
	I _R	$V_R = 1200 \text{ V}, T_j = 250 ^{\circ}\text{C}$		25	200		
Total capacitive charge	Q_{C}		$V_{R} = 400 \text{ V}$		17		nC
	QC	$I_F \le I_{F,MAX}$ $dI_F/dt = 200 \text{ A/µs}$	$V_R = 960 \text{ V}$		29		
Switching time	+	$T_i = 210 ^{\circ}\text{C}$	V _R = 400 V		< 25		ns
	ts	$V_{R} = 960 \text{ V}$		\ 25		113	
		$V_R = 1 \text{ V, } f = 1 \text{ MHz, } T_j = 25 ^{\circ}\text{C}$		237			
Total capacitance	С	$V_R = 400 \text{ V}, f = 1 \text{ MHz}, T_j = 25 ^{\circ}\text{C}$		25		pF	
		$V_R = 1000 \text{ V}, f = 1 \text{ MH}$	$Iz, T_j = 25 °C$		20		



Figures:

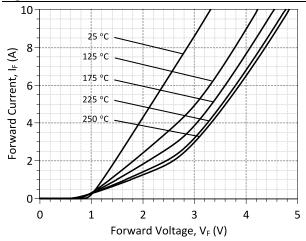


Figure 1: Typical Forward Characteristics

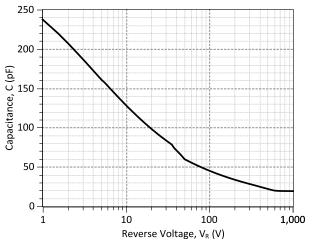


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

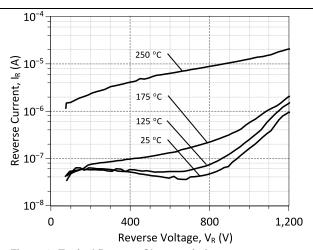


Figure 2: Typical Reverse Characteristics

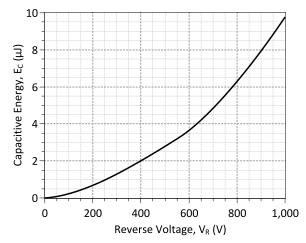


Figure 4: Typical Capacitive Energy vs Reverse Voltage Characteristics

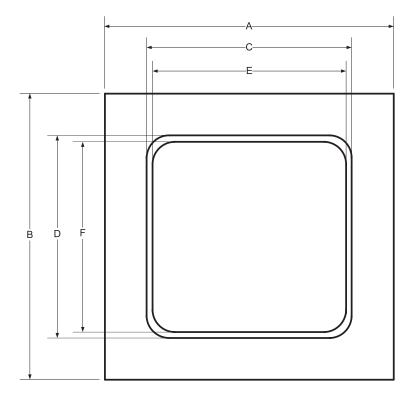
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Mechanical Parameters

Die Dimensions	1.6 x 1.6			
Anode pad size	1.34 x 1.34	mm ²		
Die Area total / active	2.56/1.69			
Die Thickness	360	μm		
Wafer Size	100	mm		
Flat Position	0	deg		
Die Frontside Passivation	Polyimide	Polyimide		
Anode Pad Metallization	4000 nm Al	4000 nm Al		
Backside Cathode Metallization	400 nm Ni + 200 nm Ai	400 nm Ni + 200 nm Au		
Die Attach	Electrically conductive glue or	Electrically conductive glue or solder		
Wire Bond	AI ≤ 350 μm	Al ≤ 350 μm		
Reject ink dot size	Φ ≥ 0.3 mm	Φ ≥ 0.3 mm		
Pagammandad ataraga anyiranmant	Store in original container, in dry	Store in original container, in dry nitrogen,		
Recommended storage environment	< 6 months at an ambient tempera	< 6 months at an ambient temperature of 23 °C		

Chip Dimensions:



DIE	A [mm]	1.6	
	B [mm]	1.6	
METAL	C [mm]	1.34	
	D [mm]	1.34	
WIRE BONDABLE	E [mm]	1.3	
	F [mm]	1.3	



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Revision History						
Date	Revision	Comments	Supersedes			
2015/02/09	1	Inserted Mechanical Parameters				
2012/04/03	0	Initial release				

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

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SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit_sic/baredie/schottky/GB05SHT12-CAL_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GB05SHT12-CAL.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.0
     $Date: 05-SEP-2013
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
     COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
 Start of GB05SHT12-CAL SPICE Model
.SUBCKT GB05SHT12 ANODE KATHODE
R1 ANODE INT R=((TEMP-24)*0.0021); Temperature Dependant Resistor
D1 INT KATHODE GB05SHT12 25C; Call the 25C Diode Model
D2 ANODE KATHODE GB05SHT12 PIN; Call the PiN Diode Model
.MODEL GB05SHT12 25C D
+ IS
          4.45E-15
                           RS
                                      0.206
+ N
          1.18144
                                      112.92
                           IKF
+ EG
          1.2
                           XTI
+ CJO
          3.00E-10
                           VJ
                                      0.419
                                      0.5
+ M
          1.6
                           FC
+ TT
          1.00E-10
                                      1200
                           BV
+ IBV
          1.00E-03
                           VPK
                                      1200
+ IAVE
                                      SiC Schottky
                           TYPE
          GeneSiC Semiconductor
+ MFG
.MODEL GB05SHT12 PIN D
          2.93E-12
                                      0.35326
+ IS
                           RS
+ N
          4.6113
                           IKF
                                      0.0043236
+ EG
          3.23
                           XTI
                                      60
+ FC
          0.5
                           TT
          1200
                           IBV
                                      1.00E-03
+ BV
+ VPK
          1200
                           IAVE
                                      2.5
+ TYPE
          SiC PiN
.ENDS
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^{*} End of GB05SHT12-CAL SPICE Model

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Authorized Distributor

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